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Examiner Initials*	Cite No ¹	item	(book, r	the auti nagazin nu	hor (in CAP e, journal, s mber(s), pu	TAL LETTERS), title of the artic erial, symposium, catalog, etc.) blisher, city and/or country when	e published		T²	
DHK		With Er	hanced	Device	Performa	onal Bandgap Engineering in nce and Scalability," IEEE 20				
PHIL		Selective on June	e Silico	n-Germ chnolog	nanium Tee gy 2001, Ja i-1-6	v Source/Drain Junctions for chnology," Extended Abstrac apan Society of Applied Physi	cs, 2001. ISBN 4-89	sing orkshop 9114-019-		
phK		transco	nductar	nce in N	licide induc MOS transi: . 20.1.1-20	ced pattern density and orientstors," IEEE 1999. IMEC, Be .1.4.	lation dependent ligium and INSYS, B	elgium.		
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Examiner		K	anel	und	ac_		Considered	06-03	-64	

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is attached.

This collection of information is required by 37 CFR 1.97 and 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to This collection of information is required by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 2 hours to complete including gathering, preparing, and process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 2 hours to complete including gathering, preparing, and process) an application form to the USPTO. Time will vary depending upon the includidual case. Any comments on the amount of time you require to complete this submitting the completed application form to the USPTO. Time will vary depending upon the includidual case. Any comments on the amount of time you require to complete this submitting the completed application form to the USPTO. Time will vary depending upon the including case. Any comments on the amount of time you require to complete this submitting the complete application form to the USPTO. Because the use of the u

Notice of References Cit d-

Application/Control No. 10/002,465	Applicant(s)/Patent Under Reexamination MURTHY ET AL.			
Examiner	Art Unit			
Junghwa M. Im	2811	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
OHP	ζA	US-5,698,869	12-1997	Yoshimi et al.	257/192
1	В	US-5,763,319	06-1998	Ling et al.	438/514
	С	US-5,990.516	11-1999	Momose et al.	257/327
	D	US-5,841,173	11-1998	Yamashita, Kyoji	257/384
	E	US-			
	F	US:			
	G	US-			
\neg	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
Juc	_ U	Kwok K. Ng. "complete guide to semiconductor device", McGraw-Hill, page 614
1	- √	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office PTO-892 (Rev. 01-2001)

Notice of References Cited

Part of Paper No. 6

King Poshee

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